

ST93003

HIGH VOLTAGE FAST-SWITCHING PNP POWER TRANSISTOR

- MEDIUM VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

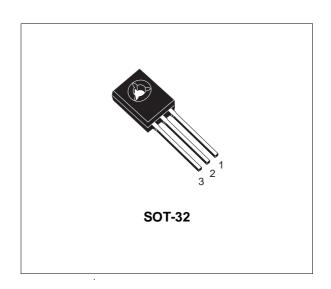
APPLICATIONS:

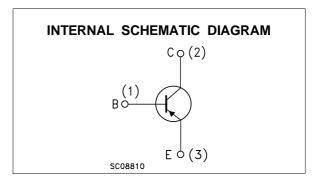
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

DESCRIPTION

The device is manufactured using high voltage Multi-Epitaxial Planar technology for high switching speeds and medium voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The ST93003 is expressly designed for a new solution to be used in compact fluorescent lamps, where it is coupled with the ST83003, its complementary NPN transistor.





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{BE} = 0)	-500	V
V_{CEO}	Collector-Emitter Voltage (I _B = 0)	-400	V
V _{EBO}	Emitter-Base Voltage $(I_C = 0, I_B = -0.75 \text{ A}, t_p < 10\mu\text{s}, T_j < 150^{\circ}\text{C})$	V _(BR) ebo	V
Ic	Collector Current	-1.5	Α
I _{CM}	Collector Peak Current (t _p < 5 ms)	-3	А
I _B	Base Current	-0.75	А
I _{BM}	Base Peak Current (t _p < 5 ms)	-1.5	А
P _{tot}	Total Dissipation at T _c = 25 °C	40	W
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

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THERMAL DATA

R _{thj-case}	Thermal Resistance Junction-case	Max	3.12	°C/W
R _{thj-amb}	Thermal Resistance Junction-ambient	Max	89	°C/W

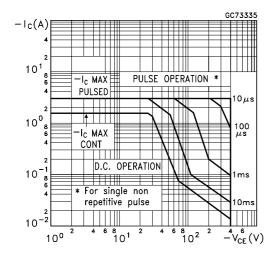
ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

Symbol	Parameter	Test	Test Conditions		Тур.	Max.	Unit
I _{CES}	Collector Cut-off Current (V _{BE} = 0)	V _{CE} = -500V V _{CE} = -500V	$T_j = 125^{\circ}C$			-1 -5	mA mA
V _{(BR)EBO}	Emitter Base Breakdown Voltage (Ic = 0)	I _E = -10 mA		-5		-10	V
V _{CEO(sus)} *	Collector-Emitter Sustaining Voltage (I _B = 0)	I _C = -10 mA L = 25 mH		-400			V
V _{CE(sat)} *	Collector-Emitter Saturation Voltage	I _C = -0.5 A I _C = -0.35 A	I _B = -0.1 A I _B = -50 mA			-0.5 -0.5	V V
V _{BE(sat)} *	Base-Emitter Saturation Voltage	I _C = -0.5 A	I _B = -0.1 A			-1	V
h _{FE} *	DC Current Gain	$I_C = -10 \text{ mA}$ $I_C = -0.35 \text{ A}$ $I_C = -1 \text{ A}$	V _{CE} = -5 V V _{CE} = -5 V V _{CE} = -5 V	10 16 4	25	32	
t _r t _s t _f	RESISTIVE LOAD Rise Time Storage Time Fall Time	$I_{C} = -0.35 \text{ A}$ $I_{B1} = -70 \text{ mA}$ $T_{p} \ge 25 \mu\text{s}$	$V_{CC} = 125 V$ $I_{B2} = 70 \text{ mA}$ (see Figure 2)	1.5	90 2.2 0.1	2.9	ns µs µs
t _s	INDUCTIVE LOAD Storage Time Fall Time	$I_C = -0.5 A$ $V_{BE(off)} = 5 V$ $V_{clamp} = 300 V$	$I_{B1} = -0.1 A$ L = 10 mH (see Figure 1)		400 40		ns ns
E _{sb}	Avalanche Energy	$L = 4 \text{ mH}$ $I_{BR} \le 2.5 \text{ A}$	C = 1.8 nF $25^{\circ}\text{C} < \text{T}_{\text{C}} < 125^{\circ}\text{C}$	12			mJ

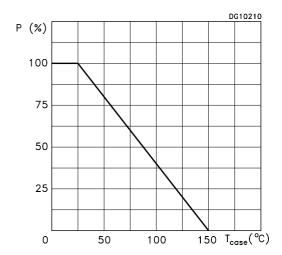
^{*} Pulsed: Pulse duration = 300µs, duty cycle = 1.5 %

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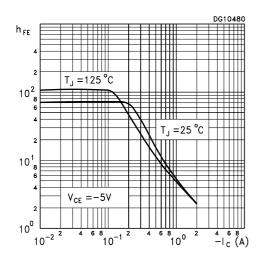
Safe Operating Area



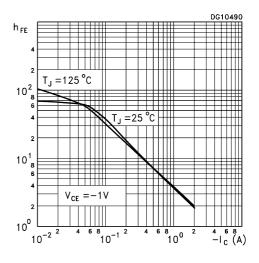
Derating Curve



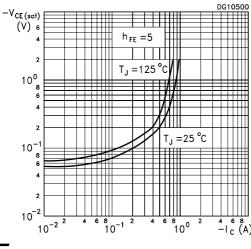
DC Current Gain



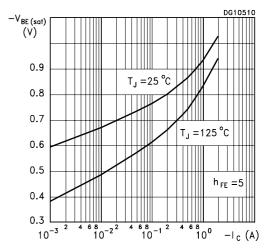
DC Current Gain



Collector Emitter Saturation Voltage

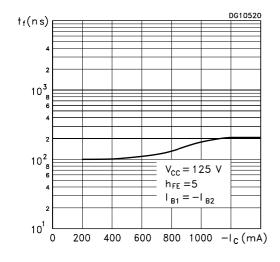


Base Emitter Saturation Voltage

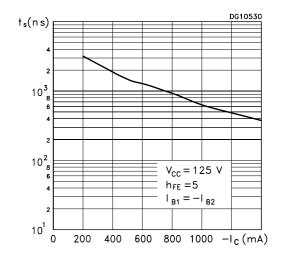


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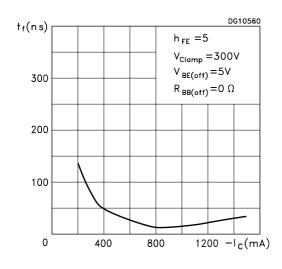
Resistive Fall Time



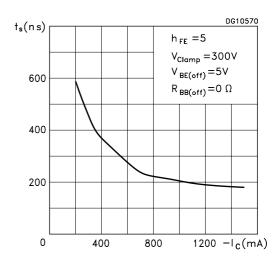
Resistive Storage Time



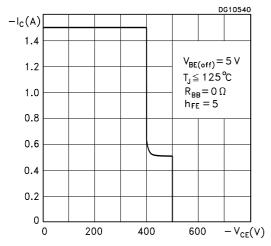
Inductive Fall Time



Inductive Storage Time



Reverse Biased SOA



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Figure 1: Inductive Load Switching Test Circuit.

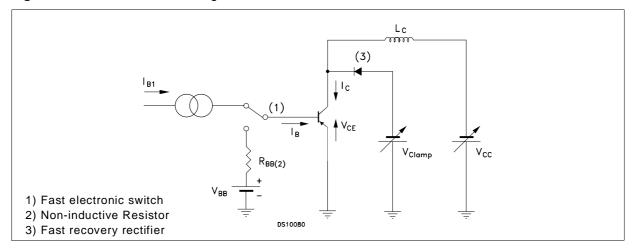
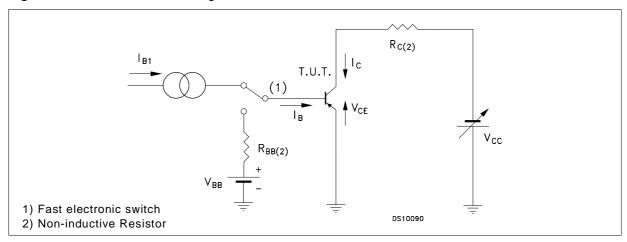


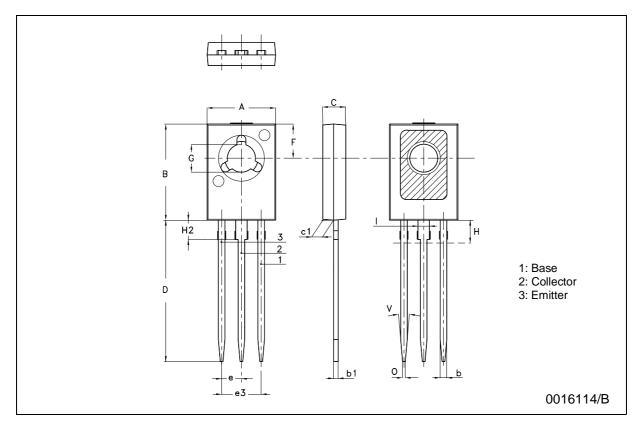
Figure 2: Resistive Load Switching Test Circuit.



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SOT-32 (TO-126) MECHANICAL DATA

DIM.		mm			inch	
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	7.4		7.8	0.291		0.307
В	10.5		10.8	0.413		0.425
b	0.7		0.9	0.028		0.035
b1	0.40		0.65	0.015		0.025
С	2.4		2.7	0.094		0.106
c1	1.0		1.3	0.039		0.051
D	15.4		16.0	0.606		0.630
е		2.2			0.087	
e3		4.4			0.173	
F		3.8			0.150	
G	3		3.2	0.118		0.126
Н			2.54			0.100
H2		2.15			0.084	
I		1.27			0.05	
0		0.3			0.011	
V		10°			10°	



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